

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/877,622	LIU ET AL.		
Examiner	Art Unit		
Jennifer T. Nguyen	2629		

	SEARCHED				
Class	Subclass	Date	Examiner		
345	173	518106	JN		
	174_				
	179				
178	18.01				
	18.03-				
	18.08				
	19.01-				
	19.07				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
345	173 - 179	518106	210		
178	18.01-18.0	518106	الان		
	19.01-19.07				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East searly	5/9/86	W